

# **400 MHz Low Power 2:8 Fan-Out Buffer with Universal Inputs and Outputs**

**Check for Samples: [CDCUN1208LP](http://www.ti.com/product/cdcun1208lp#samples)**

# <span id="page-0-0"></span>**<sup>1</sup>FEATURES**

- 
- **• Configuration Options (via pins or SPI/I<sup>2</sup>C): – Differential Mode: up to 400 MHz**
	- **– Input Type (HCSL, LVDS, LVCMOS) – LVCMOS Mode: up to 250 MHz**
	-
	-
	- **– Clock Input Divide Value (/1, /2, /4, /8) – IN2 • Wide Supply Range (1.8V, 2.5V, or 3.3V) only**
- **• Low Power Consumption and Power APPLICATIONS Operation and Output Enable Control Express)**
- **• Integrated Voltage Regulators Improve PSNR • Computing Systems (Ethernet, PCIe, USB)**
- - **– 200 fs RMS (10kHz-20MHz), LVDS at • Office Automation 100MHz**
	- **– 160 fs RMS (10kHz-20MHz), HCSL at 100MHz**
- **• Support PCIE gen1, gen2, gen3 • Maximum Operating Frequency:**
	-
	-
- **– Output Type (HCSL, LVDS, LVCMOS) • ESD Protection Exceeds 2kV HBM, 500V CDM**
- **– Signal Edge Rate (Slow, Medium, Fast) • Industrial Temperature Range (–40°C to 85°C)**
	-

- **Management Features Including 1.8V • Communications Systems (Ethernet, PCI**
	-
- **• Excellent Additive Jitter Performance • Consumer (Set top boxes, video equipment)**
	-

# **DESCRIPTION**

The CDCUN1208LP is a 2:8 fan-out buffer featuring a wide operating supply range, two universal differential/single-ended inputs, and universal outputs (HCSL, LVDS, or LVCMOS) with edge rate control. The clock buffer supports PCIE gen1, gen2 and gen3. One of the device inputs includes a divider that provides divide values of /1, /2, /4, or /8. The CDCUN1208LP is offered in a 32 pin QFN package reducing the solution footprint. The device is flexible and easy to use. The state of certain pins determines device configuration at power up. Alternately, the CDCUN1208LP provides a SPI/I<sup>2</sup>C port with which a host processor controls device settings. The CDCUN1208LP delivers excellent additive jitter performance, and low power consumption. The output section includes four dedicated supply pins enabling the operation of output ports from different power supply domains. This provides the ability to clock devices switching at different LVCMOS levels without the need for external logic level translation circuitry.

<span id="page-0-1"></span>

#### **Figure 1. CDCUN1208LP Applications – HCSL and LVDS Fan-Out Buffer Mode**

Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



SCAS928B –MAY 2012–REVISED JULY 2013 **[www.ti.com](http://www.ti.com)**

These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.



**Figure 2. CDCUN1208LP Typical Application Example – LVCMOS Output Mode**





#### **PIN FUNCTIONS(1)**



(1) This pin list applies to operation of the device in pin mode. In host mode, certain pins take on an alternate function as outlined in [Table](#page-23-0) 9.

SCAS928B –MAY 2012–REVISED JULY 2013 **[www.ti.com](http://www.ti.com)**

**STRUMENTS** 

**EXAS** 

# **PIN FUNCTIONS[\(1\)](#page-3-0) (continued)**



#### **ORDERING INFORMATION**

<span id="page-3-0"></span>

## **ABSOLUTE MAXIMUM RATINGS**

over operating free-air temperature range (unless otherwise noted) (1)



(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute–maximum–rated conditions for extended periods may affect device reliability.

(2) All supply voltages must be supplied simultaneously

(3) The input and output negative voltage ratings may be exceeded if the input and output clamp–current ratings are observed.



### **THERMAL INFORMATION**



(1) For more information about traditional and new thermal metrics, see the *IC Package Thermal Metrics* application report, [SPRA953](http://www.ti.com/lit/pdf/spra953).

## **RECOMMENDED OPERATING CONDITIONS**

 $T_A = -40^{\circ}$ C TO 85 $^{\circ}$ C

<span id="page-4-0"></span>

(1) For proper device operation, the core power supply voltage (pin 5) must be applied either before the application of any output power supply or simultaneously with the application of the output power supplies. The application of an output power supply prior to the application of the core power supply could result in improper device behavior.

(2) A minimum  $V_{DD}$  slew rate of 6500V/s should be obtained to ensure proper device functionality in Pin Mode. If the ambient temperature of the device is >0°C, the slew rate can be as slow as 5000V/s. In Host Mode (I<sup>2</sup>C/SPI), the V<sub>DD</sub> slew rate is not limited, if the Reset bit gets toggled after  $V_{DD}$  ramp.

<b>PARAMETER</b>	DEVICE SETTINGS (See Table 2) <sup>(1)</sup>							<b>TEST</b>		<b>MAX CURRENT</b>	<b>MAX CURRENT</b>	
	<b>MODE</b>	<b>OE</b>	<b>ERC</b>	<b>OTTP</b>	<b>INSEL</b>	<b>ITTP</b>	PD Bit	<b>CONFIGURATION</b>	<b>DESCRIPTION</b>	$V_{DD} = 1.8V$ $f_{OUT} = f_{in} = 100 \text{ MHz}$	$V_{DD} = 3.3V$ $f_{\text{OUT}} = f_{\text{in}} = 100 \text{MHz}$	<b>UNIT</b>
$I_{PD1.8,3.3}$	L or H		X	X	X		H	<b>Host Configuration</b> Mode (see Host <b>Configuration Mode)</b>	Device Power Down	3	$\overline{4}$	mA
CORE1.8,3.3	O		X	X	X		X	Figure 19a,b,c	Device Outputs Off	26	35	mA
$I_{HCSL1.8,3.3}$	$\Omega$	H	$\Omega$	H		$\Omega$	X	Figure 19a	<b>HCSL Buffer Current</b> Consumption <sup>(2)</sup>	23	23	mA
I <sub>LVDS1.8.3.3</sub>	$\Omega$	H	O	L		$\Omega$	X	Figure 19b	<b>LVDS Buffer Current</b> Consumption <sup>(2)</sup>	9	9	mA
I <sub>LVCMOS1.8,3.3</sub>	O	H	$\circ$	$\circ$	L.	$\Omega$	X	Figure 19c	<b>LVCMOS Buffer</b> <b>Current Consumption</b> (one side) $(2)$	8	11	mA
IDEV-HCSL1.8.3.3	O	H	$\circ$	H	L.	$\Omega$	X	Figure 19a	<b>Device Current</b> Consumption - HCSL Mode	200	200	mA
IDEV-LVDS1.8.3.3	O	H	O	L	L	$\circ$	X	Figure 19b	<b>Device Current</b> Consumption - LVDS Mode	80	90	mA

**Table 1. CDCUN1208LP Power Consumption (** $T_A$  **=**  $-40^{\circ}$ **C to 85** $^{\circ}$ **C)** 

(1)  $H = Input High, L = Input Low; O = Input Open$ 

(2) Buffer current consumption values represent the average of the current drawn by  $V_{DDO1}$ ,  $V_{DDO2}$ ,  $V_{DDO3}$ , and  $V_{DDO4}$  divided by 8 (differential mode) or 16 (single-ended mode).

**EXAS ISTRUMENTS** 

# SCAS928B –MAY 2012–REVISED JULY 2013 **[www.ti.com](http://www.ti.com)**





## <span id="page-5-0"></span>**DIGITAL INPUT ELECTRICAL CHARACTERISTICS – OE (SCL), INSEL, ITTP, OTTP, DIVIDE (SDA/MOSI), ERC(ADDR/CS), MODE**

 $T_A = -40$ °C to 85°C

<span id="page-5-1"></span>

## **UNIVERSAL INPUT (IN1, IN2) CHARACTERISTICS**

### $V_{DD} = 1.8V$ , 2.5V, 3.3V,  $T_A = -40^{\circ}$ C to 85°C



(1) When using an input in single-ended mode, ground the negative terminal (IN1N and/or IN2N) and drive the positive terminal (IN1P and/or IN2P).



#### **[www.ti.com](http://www.ti.com)** SCAS928B –MAY 2012–REVISED JULY 2013

# <span id="page-6-0"></span>**CLOCK OUTPUT BUFFER CHARACTERISTICS (OUTPUT MODE = LVDS)**

Unless otherwise noted,  $V_{DDOX} = 1.8V$ , 2.5V, 3.3V;  $T_A = -40^{\circ}C$  to 85°C. See [Figure](#page-13-2) 9, Figure 10, and Figure 11.



(1) t<sub>Rfin</sub> = t<sub>Ffin</sub> > 0.6 V/ns.<br>(2) Parameter depends significantly on power supply design and supply voltage rise time.

SCAS928B –MAY 2012–REVISED JULY 2013 **[www.ti.com](http://www.ti.com)**

# <span id="page-7-0"></span>**CLOCK OUTPUT BUFFER CHARACTERISTICS (OUTPUT MODE = HCSL)**

Unless otherwise noted,  $V_{DDOx}$  = 1.8V, 2.5V, 3.3V; T<sub>A</sub> = -40°C to 85°C. See [Figure](#page-14-1) 12, Figure 13, and Figure 14. Supporting PCIE gen1, gen2, gen3.



(1) Single-ended measurement includes overshoot. Measurement is taken at load capacitors C<sub>L</sub> (see [Figure](#page-13-3) 12).<br>(2) Single-ended measurement, includes undershoot Measurement is taken at load capacitors C<sub>L</sub> (see Figure 12)

(2) Single-ended measurement, includes undershoot Measurement is taken at load capacitors  $C_L$  (see [Figure](#page-13-3) 12).<br>(3) Measurement is taken at load capacitors  $C_L$  (see Figure 12). If VDDOx = 1.8V, the specified minimum V<sub>OH</sub> Measurement is taken at load capacitors C<sub>L</sub> (see [Figure](#page-13-3) 12). If VDDOx = 1.8V, the specified minimum V<sub>OH</sub> is 550 mV.

 $(4)$  TSTABLE is the time the differential clock must maintain a minimum  $±150$  mV differential voltage after rising/falling edges before it is allowed to droop back into the VRB ±100 mV differential range. See [Figure](#page-8-2) 5.

(5)  $t_{Rfin} = t_{Ffin} \geq 0.6$  V/ns.

(6) Measured from –150 mV to +150 mV on the differential waveform. The signal must be monotonic through the measurement region for rise and fall time. The 300 mV measurement window is centered on the differential zero crossing. Slow is 0.53V/ns, medium is 1.05V/ns, and fast is 2.1V/ns. The PCIe CEM spec. has a window of 0.6V/ns to 4V/ns.

(7) Assumes input duty cycle = 50%.

(8) Skew measured between identical output types with identical loads, identical output power supplies, and identical edge rate settings.

(9) Parameter depends significantly on power supply design and supply voltage rise time.









<span id="page-8-0"></span>



<span id="page-8-1"></span>

**Figure 5. HCSL Ring Back Margin and Timing**

<span id="page-8-2"></span>



<span id="page-8-4"></span><span id="page-8-3"></span>



**FXAS NSTRUMENTS** 

<span id="page-9-0"></span>





# <span id="page-10-0"></span>**CLOCK OUTPUT BUFFER ELECTRICAL CHARACTERISTICS (OUTPUT MODE = LVCMOS)**

Unless otherwise noted,  $V_{DDOx}$  as shown in Table sections,  $T_A = -40^{\circ}C$  to 85°C. ERC = Fast. For test configurations, see [Figure](#page-14-2) 15 and [Figure](#page-14-3) 16.



(1) The  $t_{s(k_0)}$  specification is only valid for equal loading with identical edge rates and output supply voltages..

(2) Assumes 50% duty cycle at the input(s)

(3) odc depends on output rise and fall time  $(t_R/t_F)$ .

(4) Parameter depends significantly on power supply design and supply voltage rise time.

SCAS928B –MAY 2012–REVISED JULY 2013 **[www.ti.com](http://www.ti.com)**

**STRUMENTS** 

**EXAS** 

## **CLOCK OUTPUT BUFFER ELECTRICAL CHARACTERISTICS (OUTPUT MODE = LVCMOS) (Continued)**

Unless otherwise noted,  $V_{DDOx}$  as shown in Table sections,  $T_A = -40^{\circ}C$  to 85°C. ERC = Fast. For test configurations, see [Figure](#page-14-2) 15 and [Figure](#page-14-3) 16.



(1) The  $t_{sk(0)}$  specification is only valid for equal loading with identical edge rates and output supply voltages..

(2) Assumes 50% duty cycle at the input(s)<br>(3) odc depends on output rise and fall time odc depends on output rise and fall time ( $t_R/t_F$ ).

(4) Parameter depends significantly on power supply design and supply voltage rise time.



### **CLOCK OUTPUT BUFFER ELECTRICAL CHARACTERISTICS (OUTPUT MODE = LVCMOS) (Continued)**

Unless otherwise noted,  $V_{DDOx}$  as shown in Table sections,  $T_A = -40^{\circ}C$  to 85°C. ERC = Fast. For test configurations, see [Figure](#page-14-2) 15 and [Figure](#page-14-3) 16.



(1) The t<sub>sk(o)</sub> specification is only valid for equal loading with identical edge rates and output supply voltages.<br>(2) Assumes 50% duty cycle at the input(s)

(3) odc depends on output rise and fall time  $(t_R/t_F)$ .

(4) Parameter depends significantly on power supply design and supply voltage rise time.

SCAS928B –MAY 2012–REVISED JULY 2013 **[www.ti.com](http://www.ti.com)**



## <span id="page-13-0"></span>**TEST CONFIGURATIONS**







<span id="page-13-1"></span>**Figure 10. CDCUN1208LP LVDS Output - Propagation Delay/Skew Measurement Setup**



**Figure 11. CDCUN1208LP LVDS Output - Phase Noise/Jitter Measurement Setup**

<span id="page-13-2"></span>[Figure](#page-13-3) 12 shows the configuration used to measure the HCSL buffer characteristics. Either single ended probes with math or differential probes can be used for differential measurements. The 50Ω differential trace length is up to 15 inches.



<span id="page-13-3"></span>**Figure 12. CDCUN1208LP HCSL Output – Measurement Configuration with Load**





**Figure 13. CDCUN1208LP HCSL Output – Propagation Delay/Skew Measurement**

<span id="page-14-0"></span>

<span id="page-14-1"></span>**Figure 14. CDCUN1208LP HCSL Output – Phase Noise/Jitter Measurement Configuration**



<span id="page-14-2"></span>**Figure 15. CDCUN1208LP LVCMOS Output – Measurement Configuration**



<span id="page-14-3"></span>**Figure 16. CDCUN1208LP LVCMOS Output – Phase Noise/Jitter Measurement Setup**





**Figure 17. CDCUN1208LP Universal Input - Differential Mode Measurement Setup**



**Figure 18. CDCUN1208LP Universal Input - Single-Ended Mode Measurement Setup**



<span id="page-15-0"></span>**Figure 19. CDCUN1208LP Power Consumption Measurement Setup**



#### **PERFORMANCE CHARACTERISTICS**







**Figure 22. CDCUN1208LP LVCMOS Signal Swing Figure 23. CDCUN1208LP LVCMOS Signal Swing Characteristics (3.3V Mode) Characteristics (2.5V Mode)**







### **TEXAS INSTRUMENTS**

# **[CDCUN1208LP](http://www.ti.com/product/cdcun1208lp?qgpn=cdcun1208lp)**

SCAS928B –MAY 2012–REVISED JULY 2013 **[www.ti.com](http://www.ti.com)**











**Characteristics (1.8V Mode) Load Drive Characteristics (3.3V Mode)**



**Figure 26. CDCUN1208LP LVCMOS Capacitive Figure 27. CDCUN1208LP LVCMOS Capacitive Load Drive Characteristics (2.5V Mode) Load Drive Characteristics (1.8V Mode)**

18 *Submit [Documentation](http://www.go-dsp.com/forms/techdoc/doc_feedback.htm?litnum=SCAS928B&partnum=CDCUN1208LP) Feedback* Copyright © 2012–2013, Texas Instruments Incorporated



### **FUNCTIONAL DESCRIPTION**

### **DEVICE CONTROL USING CONFIGURATION PINS**

<span id="page-18-2"></span>[Figure](#page-18-1) 28 illustrates and [Table](#page-18-0) 2 lists the CDCUN1208LP device settings using the configuration pins. Some pins sense three different states (HIGH, LOW, OPEN) according to [Figure](#page-18-1) 28 and DIGITAL INPUT [ELECTRICAL](#page-5-0) [CHARACTERISTICS](#page-5-0) – OE (SCL), INSEL, ITTP, OTTP, DIVIDE (SDA/MOSI), ERC(ADDR/CS), MODE. The device samples the state of the pins at power up and configures the device accordingly. Certain pins including INSEL and OE are sampled continuously; thus changes of state of INSEL or OE controls the device instantly.



**Figure 28. CDCUN1208LP Pin Configuration Overview**

<span id="page-18-1"></span><span id="page-18-0"></span>



Copyright © 2012–2013, Texas Instruments Incorporated *Submit [Documentation](http://www.go-dsp.com/forms/techdoc/doc_feedback.htm?litnum=SCAS928B&partnum=CDCUN1208LP) Feedback* 19

SCAS928B –MAY 2012–REVISED JULY 2013 **[www.ti.com](http://www.ti.com)**



#### **Configuration of Output Type (OTTP)**

[Table](#page-19-0) 3 shows how to set the output buffer type using the OTTP pin. This setting affects all device outputs equally. Certain combinations of output buffers include a dedicated power supply pin which must be properly bypassed. If the device output configuration is set to LVCMOS, then the supply voltage applied establishes the switching thresholds corresponding to the supply provided according to CLOCK [OUTPUT](#page-10-0) BUFFER ELECTRICAL [CHARACTERISTICS](#page-10-0) (OUTPUT MODE = LVCMOS). For example, if OUT1 and OUT2 are supplied with a 1.8V power supply via the VDDO1 pin, the switching thresholds are set to the 1.8V logic domain. The system may have other logic supplies (1.8V, 2.5V, or 3.3V) connected to the device on different output buffer supply domains simultaneously. This enables the device to clock devices operating on different supplies without the need for external logic level translation buffers. The CDCUN1208LP automatically adjusts the switching thresholds corresponding to these common logic power supply voltages. For more information regarding the power supplies for the output section, see DEVICE POWER SUPPLY [CONNECTIONS](#page-33-0) AND [SEQUENCING](#page-33-0).





#### <span id="page-19-0"></span>**Configuration of Edge Rate Control (ERC)**

The CDCUN1208LP supports Edge Rate Control (ERC) used to tailor jitter and EMI performance from device outputs. [Table](#page-19-1) 4 shows the edge rate control setting. This setting affects all device outputs equally. Each edge rate setting is unique to the output buffer type selected as described in CLOCK [OUTPUT](#page-6-0) BUFFER [CHARACTERISTICS](#page-6-0) (OUTPUT MODE = LVDS), CLOCK OUTPUT BUFFER [CHARACTERISTICS](#page-7-0) (OUTPUT MODE = [HCSL\),](#page-7-0) and CLOCK OUTPUT BUFFER ELECTRICAL [CHARACTERISTICS](#page-10-0) (OUTPUT MODE = [LVCMOS\).](#page-10-0)





#### <span id="page-19-1"></span>**Control of Output Enable (OE)**

<span id="page-19-3"></span><span id="page-19-2"></span>[Table](#page-19-2) 5 shows how the output enable pin controls the device outputs. The OE pin is sampled continuously so that the application may turn on/off the output buffers at any time.





(1) Leaving the Output Enable pin OPEN will cause the CDCUN1208LP to malfunction. This pin must be driven high or low at all times



## **INPUT PORTS (IN1, IN2)**

### **Configuration of the Input Type (ITTP)**

<span id="page-20-0"></span>[Table](#page-20-0) 6 describes how to set the input buffers to the appropriate switching levels using the ITTP pin. For proper input termination, see [Figure](#page-33-1) 44.



#### **Table 6. CDCUN1208LP Pin Control of Input Type (ITTP)**

#### **Configuration of the IN2 Divider (INDIV)**

<span id="page-20-1"></span>[Table](#page-20-1) 7 describes how to set the input divider using the DIVIDE pin. If the /8 setting is desired, then this feature is accessed via the host configuration method only refer to section DEVICE [CONTROL](#page-22-0) USING THE HOST [INTERFACE.](#page-22-0)



#### **Table 7. CDCUN1208LP Pin Control of INDIV Divider**

SCAS928B –MAY 2012–REVISED JULY 2013 **[www.ti.com](http://www.ti.com)**



## **SMART INPUT MULTIPLEXER (INMUX)**

The Smart Multiplexer supports manual and automatic switching between IN1 and IN2. If enabled, the Smart Multiplexer switches automatically between clock inputs based on a prioritization scheme shown in [Table](#page-21-0) 8. If using the Smart Multiplexer Auto Mode, the frequencies of the clocks applied to the smart multiplexer via IN1 and IN2 (via the divider) may differ by up to 20%. The phase relationship between clock inputs has no restriction. The smart multiplexer includes signal conditioning that provides glitch suppression.<sup>(1)</sup>

Upon the detection of a loss of signal on the input with higher priority, the smart multiplexer switches over to the other clock input on the first incoming rising edge. During this switching operation, the output of the smart multiplexer is low. Upon restoration of the higher priority clock, the smart multiplexer waits until it detects four complete cycles from the higher priority clock prior to switching the output of the smart multiplexer back to the higher priority clock. During this switching operation, the output of the smart multiplexer remains high until the next falling edge as shown in [Figure](#page-21-1) 29.

#### **Pin Configuration of the Smart Input Multiplexer (INMUX)**

[Table](#page-21-0) 8 shows how to control the Smart Input Multiplexer. In Pin Configuration mode, the INSEL pin is sampled continuously so that the application may select the input clock at any time.

<span id="page-21-0"></span>

#### **Table 8. Control of INMUX via the INSEL Pin**



**Figure 29. CDCUN1208LP Smart Multiplexer Operation**

<span id="page-21-1"></span>(1) This implementation does not implement a phase build-out mechanism; rather, analog filtering insuring a smooth transition at device outputs.



## <span id="page-22-0"></span>**DEVICE CONTROL USING THE HOST INTERFACE**

Host configuration mode affords a greater degree of flexibility. Unlike pin configuration mode in which the pin settings affect the entire device, host configuration mode enables the user to apply different settings to each input and output port as depicted in [Figure](#page-22-1) 30. This includes the ability to mix and match output type, edge rate control, and output enable settings. The host interface is enabled/selected by strapping the MODE pin either high (for I<sup>2</sup>C) or low (for SPI) and resetting the device. Additional device features are accessible only through the host interface as well. For instance, the user can configure the input divider (IDIV) to /8 in host configuration mode only. Additionally, the system can power down the device through device registers.

#### **OE and INSEL in Host Configuration Mode**

In host configuration mode, the OE pin is no longer available; therefore buffers are controlled individually via the host interface. The input multiplexer can be controlled either via the pin or via the device registers in accordance with [Table](#page-25-0) 11.



<span id="page-22-1"></span>**Figure 30. CDCUN1208LP Host Configuration – Typical Application**

SCAS928B –MAY 2012–REVISED JULY 2013 **[www.ti.com](http://www.ti.com)**

**[CDCUN1208LP](http://www.ti.com/product/cdcun1208lp?qgpn=cdcun1208lp)**

<span id="page-23-0"></span>

## **Table 9. CDCUN1208LP Host Configuration Pins**

The CDCUN1208LP samples the MODE pin after the device exits the power on reset (POR) state. The device is placed in the RESET state in one of two ways: a power on reset (POR) circuit automatically resets the device after power is applied; or through the RESET bit (R15[1]) in register memory (see [Table](#page-25-0) 11). This RESET bit is only accessable in host configuration mode. If the MODE pin (pin 11) is open (no connection), then the device is placed in the pin configuration mode and all settings are determined by the state of various pins according to [Table](#page-18-0) 2 and [Figure](#page-18-1) 28. If the MODE pin is low, then device enables the SPI interface; and, if MODE is high, then I <sup>2</sup>C is enabled.







## **DEVICE REGISTERS**

#### **Device Registers: Register 00-07**

Register 00: OUT1 Register 01: OUT2 Register 02: OUT3 Register 03: OUT4 Register 04: OUT5 Register 05: OUT6 Register 06: OUT7 Register 07: OUT8

## **Table 10. CDCUN1208LP Register 0–7 Bit Definitions**

<span id="page-24-1"></span><span id="page-24-0"></span>



<span id="page-25-0"></span>

### **Table 11. CDCUN1208LP Registers 11–15 Bit Definitions**

(1) When configuring device inputs as LVCMOS, apply the signal-ended clock signal to INxP and leave INxN either floating or ground it. The power supply voltage (1.8V, 2.5V, or 3.3V) applied to V<sub>DD</sub> (pin 5) establishes the switching thresholds for IN1 and IN2 in LVCMOS mode.



## **HOST INTERFACE HARDWARE INFORMATION**

#### **SPI Communication**

A SPI communication link includes a master and one or more slaves. [Table](#page-23-0) 9 lists the four signal lines that form a SPI communication link. [Figure](#page-26-0) 32 shows the format for SPI messages. The SPI master (host) initiates communication by asserting SCS low. Information on SDI/SDO is latched on each rising edge of SCL. The first bit transmitted on SDI establishes the direction of the SPI transfer. Next, the master transmits the address to be written/read (up to 15 bits). If the operation is a write, the master transmits 16 data bits on SDI. If the transfer is a read, the slave transmits 16 data bits on SDO (the master continues to clock the transfer via SCL). [Figure](#page-27-0) 34 and [Table](#page-27-1) 12 show the timing specifications for SPI.



**Figure 32. SPI Message Format**

#### <span id="page-26-0"></span>**CDCUN1208LP SPI Addressing**

[Figure](#page-26-1) 33 shows how to construct the address field for SPI messages to/from the CDCUN1208LP. The device is assigned a 4-bit fixed address (0001b). In order for the host to communicate with the CDCUN1208LP, the address must include this fixed value in the correct position for the device to recognize the message.



<span id="page-26-1"></span>**Figure 33. CDCUN1208LP Device Addressing - SPI Mode**

SCAS928B –MAY 2012–REVISED JULY 2013 **[www.ti.com](http://www.ti.com)**



#### **Writing to the CDCUN1208LP**

To initiate a SPI data transfer, the master (host) asserts the SCS (serial chip select) pin low (see [Figure](#page-26-0) 32). The first rising edge of the clock signal (SCL) transfers the bit presented on the SDI pin of the CDCUN1208LP. This bit signals if a read (first bit high) or a write (first bit low) will transpire. The master shifts data to the slave with each rising edge of SCL. Following the W/R bit are 4 fixed bits followed by 11 bits that specify the address of the target register in the register file (see [Figure](#page-26-1) 33). The 16 bits that follow are the data payload. If the master sends an incomplete message, (i.e. the master de-asserts the SCS pin high prior to a complete message transmission), then the slave aborts the transfer, and device makes no changes to the register file or the hardware. The master signals the slave of the completed transfer and disables the SPI port by de-asserting the SCS pin high.

#### **Reading from the CDCUN1208LP**

As with the write operation, the master first initiates a SPI transfer by asserting the SCS pin low. The host signals a read operation by shifting a logical high in the first bit position, signaling the slave that the master is initiating a read data transfer from the slave. Thereafter, the master specifies the address of interest according to [Figure](#page-26-1) 33. During the 16 clock cycles that follow, the slave presents the data from the register specified in the first half of the message on the SDO pin. The master signals the slave that the transfer is complete by de-asserting the SCS pin high.

#### **Block Write/Read Operation**

The CDCUN1208LP supports a block write and block read operation. The master need only specify the lowest address of the sequence of addresses that the host needs to access. The CDCUN1208LP will automatically increment the internal register address pointer if the SCS pin remains active low after the SPI port finishes the initial 32-bit transmission sequence. Each transmission of 16 bits (a data payload width) results in the slave automatically incrementing the address pointer (provided the SCS pin remains active low for all sequences).





<span id="page-27-1"></span><span id="page-27-0"></span>

#### **Table 12. SPI Timing Specifications**



## **I <sup>2</sup>C Communication**

The CDCUN1208LP incorporates an  $I^2C$  port compliant with  $I^2C$  Bus Specification V2.1 (7-bit addressing). Some highlights are contained herein to provide clarity with respect to how communication between the host and the CDCUN1208LP is facilitated. The I<sup>2</sup>C bus comprises two signals (clock – SCL, and data – SDA). I<sup>2</sup>C implements a master-slave protocol and supports multi-master implementations. Unlike SPI that implements a chip select signal for device level addressing and separate data signals for transmit and receive, I<sup>2</sup>C embeds the device address in the serial data stream. Because of this, devices that reside on the I<sup>2</sup>C must have a unique bus address. I<sup>2</sup>C also uses the protocol to control the direction of data flow through the data signaling line.

#### **Message Transmission**

#### *Data and Address Bits*

When transmitting address or data bits, the transmitter must only change the state of SDA when SCL is low. During the time that SCL is high, SDA must be stable (no transitions).



**Figure 35. I <sup>2</sup>C Data/Address Bit Transmission**

#### *Special Symbols – Start (S) and Stop (P)*

Messages are framed by the master by generating a START and a STOP symbol. The START symbol is signaled by transitioning the SDA line from high to low while the SCL line is high. The STOP symbol is signaled by transitioning the SDA line from low to high while the SCL line is high.



**Figure 36. I <sup>2</sup>C Bus START and STOP Symbol Generation**

#### *Special Symbols – Acknowledge (ACK)*

The acknowledge symbol must be sent by the receiver during the 9<sup>th</sup> clock cycle after the transmitter sends a byte of data. The transmitter allows the SDA pin to go high and the receiver pulls the line low to acknowledge the receipt of the byte (leaving the SDA high indicates that the byte was not received). If this occurs the transmitter issues a STOP and retransmits the message. If the receiver is not prepared to receive another byte, it can suspend transmission by holding the SDA line low during the ACK time slot. When the receiver is ready to receive another byte, it releases the SDA line.

SCAS928B –MAY 2012–REVISED JULY 2013 **[www.ti.com](http://www.ti.com)**



#### *Generic Message Frame*

[Figure](#page-29-0) 37 shows a typical format for  $I^2C$  messages. The message frame is bracketed by the START and STOP symbols (both generated by the master). If a START symbol has not been transmitted, then the bus is considered 'available'. If a START symbol has been transmitted and a STOP symbol has not been transmitted, the bus is considered 'busy'. The first 8 bits transmitted include the R/W bit and a 7-bit I<sup>2</sup>C address field. The reception of each byte grouping that is transmitted must be acknowledged by the receiver. Next, the high byte of the data pay load is transmitted (MSB first) followed by an acknowledgement by the receiver. Finally the low byte is sent. After acknowledgement, the master sends a STOP symbol to end the message frame.



**Figure 37. I <sup>2</sup>C Message Format**

### <span id="page-29-0"></span>*CDCUN1208LP Message Format*

[Figure](#page-29-1) 38 shows the format of addressing and flow control for I<sup>2</sup>C messages to/from the CDCUN1208LP. A message includes two address fields. The I<sup>2</sup>C Address is used to support multiple devices on the bus (each device must have a unique I<sup>2</sup>C address). The Register Address specifies which register of the device identified by the I<sup>2</sup>C Address is to be written/read.



**Figure 38. CDCUN1208LP I <sup>2</sup>C Message - Addressing**

### <span id="page-29-1"></span>*CDCUN1208LP Device Addressing (I<sup>2</sup>C Address)*

[Figure](#page-29-0) 38 outlines the construction of the  $I^2C$  Address shown in Figure 37. The highest 6 bits are assigned to the target device family (are unique to a specific target device family) and are 'hard wired'. The lowest address bit (A0) corresponds to address bit that can be set via pin 31 on the CDCUN1208LP (see [Table](#page-23-0) 9). This allows up to two CDCUN1208LPs to reside on the same I<sup>2</sup>C bus. The next 8 bits transmitted is called the Register Address.



#### *CDCUN1208LP Device Addressing (Register Address)*

Likewise, [Figure](#page-29-1) 38 shows the format of the register address field of the I<sup>2</sup>C message. The first bit determines if the transfer is a byte or a block (more than one byte). The CDCUN1208LP register width is 16 bits (2 bytes), therefore, generally block addressing is used to access each register in its entirety. Because the I<sup>2</sup>C protocol requires that the slave address is a 7-bit field, the leading 3-bits are all '0' while the trailing 4-bits specify the device register of interest.

#### **I <sup>2</sup>C Master/Slave Handshaking**

[Figure](#page-30-0) 39 shows the handshaking between the master (host) and the slave (CDCUN1208LP) that the  $I<sup>2</sup>C$ protocol supports. In all cases, the master drives the SCL (clock line); however, depending on the direction of transfer/acknowledgement, the master or the slave device drives SDA (data line).



**Figure 39. I <sup>2</sup>C Master/Slave Handshaking Example**

#### <span id="page-30-0"></span>**Block Read/Write**

For "Block Write/Read" operations, the bytes are accessed in sequential order from lowest to highest byte (with most significant bit first) with the ability to stop after any complete byte has been transferred. The start address of the transfer is specified in the same way a single word transfer is initiated.

SCAS928B –MAY 2012–REVISED JULY 2013 **[www.ti.com](http://www.ti.com)**



## **I <sup>2</sup>C Timing**

[Figure](#page-31-0) 40 and [Table](#page-31-1) 13 provide details regarding the timing requirements for I<sup>2</sup>C:





## **Table 13. I <sup>2</sup>C Timing Requirements**

<span id="page-31-1"></span><span id="page-31-0"></span>



### **APPLICATION INFORMATION**

#### <span id="page-32-3"></span>**PCI EXPRESS APPLICATIONS**

Texas Instruments offers a complete clock solution for PCI Express applications. The CDCUN1208LP can be used to fan out the 100MHz clock signal provided by the CDCM9102 as depicted in [Figure](#page-32-0) 41.



**Figure 41. Clock Solution for PCIE Express Applications**

<span id="page-32-0"></span>[Figure](#page-32-1) 42 shows a typical application in which the receiver is off board. The PCIe Specification (CEM2.0) requires that all source termination is on the motherboard (not on the daughter card). For this reason, the termination resistors are placed as shown. Additionally, source resistors are employed to eliminate ringing. In this case, Z<sub>L</sub> can vary between 40Ω and 60Ω and R<sub>S</sub> can range from 22Ω to 33Ω.



**Figure 42. Typical Configuration – Off Board Receiver**

<span id="page-32-2"></span><span id="page-32-1"></span>[Figure](#page-32-2) 43 shows a typical application in which the receiver is on-board. In this case, series resistors are not required to eliminate ringing as proper termination is achieved. In this case two termination resistors,  $Z_L = 49.9Ω$ are placed close to the receiver.



**Figure 43. Typical Configuration – On Board Connection**

SCAS928B –MAY 2012–REVISED JULY 2013 **[www.ti.com](http://www.ti.com)**



## <span id="page-33-0"></span>**DEVICE POWER SUPPLY CONNECTIONS AND SEQUENCING**

VDD (pin 5) is the core power supply of the device while VDDOx (pins 11, 14, 22, and 27) provide power for the output sections. The core supply must be present either before the application of the output power supplies or be present simultaneously. Applying an output power supply voltage on any of the VDDOx pins prior to the application of power to the core supply pin will potentially result in improper device operation.

VDDO2 (pin 14) and VDDO4 (pin 27) provide power for OUT1/OUT2 and OUT7/OUT8 respectively. Additionally, these pins provide power to integrated voltage regulators that condition power for two banks of outputs. For example, the regulator associated with OUT1–OUT4 receives power from the VDDO2 pin. Consequently, if the application requires one or two outputs from a bank of four, then the application must use OUT3/OUT4 and apply power via VDDO2 (1) . Likewise, the regulator that conditions power for OUT5–OUT8 receives power from VDDO4 (pin 27). If the application uses subset of OUT5–OUT8, then OUT7/OUT8 must be used. For example, if the application will use 6 of the 8 output channels, then VDDO1, VDDO2, and VDDO4 (along with OUT1–OUT4, and OUT7–OUT8) must be used. If the application requires the use of 7 of the 8 output channels, the VDDO1–VDDO4 are used, and OUT1–OUT7 or OUT1–OUT6 and OUT8 could be used.

## **DEVICE INPUTS (IN1, IN2)**

[Figure](#page-33-1) 44 shows how to interface certain common signaling formats to the device inputs of the CDCUN1208LP. This entails both proper signal termination as well as input buffer configuration via the input type (ITTP) pin.



**Figure 44. Common Interfaces to Device Inputs – DC Coupling**

<span id="page-33-1"></span>(1) If OUT1 or OUT2 are used and VDDO1 is powered but not VDDO2, the CDCUN1208LP will not function properly. Likewise, if OUT5 or OUT6 are used and VDDO3 is powered but not VDDO4, then the device will not function properly either.

## **REVISION HISTORY**

# **Changes from Original (May 2012) to Revision A Page** • Added Feature: Support PCIE gen1, gen2, gen3 ... [1](#page-0-0) • Added Feature:160 fs RMS (10kHz-20MHz), HCSL at 100MHz .. [1](#page-0-0) • Added text to the Description: "The clock buffer supports PCIE gen1, gen2 and gen3." .. [1](#page-0-1) Added text to the CLOCK OUTPUT BUFFER CHARACTERISTICS table: "Supporting PCIE gen1, gen2, gen3." ............ [8](#page-7-0) • Changed [Table](#page-19-2) 5 From: DISABLED To: DISABLED in Tri\_State .. [20](#page-19-3) • Changed [Table](#page-24-0) 10 From: Disabled To: Disabled in Tri\_State for OUTx\_PD ... [25](#page-24-1) • Added text and [Figure](#page-32-0) 41 to the PCI EXPRESS APPLICATIONS section. ... [33](#page-32-3)

### **Changes from Revision A (January 2013) to Revision B Page**





**[www.ti.com](http://www.ti.com)** SCAS928B –MAY 2012–REVISED JULY 2013



# **PACKAGING INFORMATION**



**(1)** The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

**(2)** Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check<http://www.ti.com/productcontent>for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between

the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

**(3)** MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

**(4)** There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

**(5)** Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

**Important Information and Disclaimer:**The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

# **PACKAGE MATERIALS INFORMATION**

Texas<br>Instruments

## **TAPE AND REEL INFORMATION**





# **QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE**





TEXAS<br>INSTRUMENTS

# **PACKAGE MATERIALS INFORMATION**

www.ti.com 18-Aug-2014



\*All dimensions are nominal





NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

B. This drawing is subject to change without notice.

C. QFN (Quad Flatpack No-Lead) Package configuration.

D. The package thermal pad must be soldered to the board for thermal and mechanical performance.

E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.

F. Falls within JEDEC MO-220.



# RHB (S-PVQFN-N32)

# PLASTIC QUAD FLATPACK NO-LEAD

#### THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



#### NOTE: A. All linear dimensions are in millimeters



# RHB (S-PVQFN-N32)

# PLASTIC QUAD FLATPACK NO-LEAD



NOTES: All linear dimensions are in millimeters. A.

- This drawing is subject to change without notice. **B.**
- C. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat-Pack Packages, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <http://www.ti.com>.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- E. Customers should contact their board fabrication site for recommended solder mask tolerances and via tenting recommendations for any larger diameter vias placed in the thermal pad.



#### **IMPORTANT NOTICE**

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, enhancements, improvements and other changes to its semiconductor products and services per JESD46, latest issue, and to discontinue any product or service per JESD48, latest issue. Buyers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All semiconductor products (also referred to herein as "components") are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its components to the specifications applicable at the time of sale, in accordance with the warranty in TI's terms and conditions of sale of semiconductor products. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by applicable law, testing of all parameters of each component is not necessarily performed.

TI assumes no liability for applications assistance or the design of Buyers' products. Buyers are responsible for their products and applications using TI components. To minimize the risks associated with Buyers' products and applications, Buyers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right relating to any combination, machine, or process in which TI components or services are used. Information published by TI regarding third-party products or services does not constitute a license to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of significant portions of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI components or services with statements different from or beyond the parameters stated by TI for that component or service voids all express and any implied warranties for the associated TI component or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Buyer acknowledges and agrees that it is solely responsible for compliance with all legal, regulatory and safety-related requirements concerning its products, and any use of TI components in its applications, notwithstanding any applications-related information or support that may be provided by TI. Buyer represents and agrees that it has all the necessary expertise to create and implement safeguards which anticipate dangerous consequences of failures, monitor failures and their consequences, lessen the likelihood of failures that might cause harm and take appropriate remedial actions. Buyer will fully indemnify TI and its representatives against any damages arising out of the use of any TI components in safety-critical applications.

In some cases, TI components may be promoted specifically to facilitate safety-related applications. With such components, TI's goal is to help enable customers to design and create their own end-product solutions that meet applicable functional safety standards and requirements. Nonetheless, such components are subject to these terms.

No TI components are authorized for use in FDA Class III (or similar life-critical medical equipment) unless authorized officers of the parties have executed a special agreement specifically governing such use.

Only those TI components which TI has specifically designated as military grade or "enhanced plastic" are designed and intended for use in military/aerospace applications or environments. Buyer acknowledges and agrees that any military or aerospace use of TI components which have *not* been so designated is solely at the Buyer's risk, and that Buyer is solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI has specifically designated certain components as meeting ISO/TS16949 requirements, mainly for automotive use. In any case of use of non-designated products, TI will not be responsible for any failure to meet ISO/TS16949.



Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2014, Texas Instruments Incorporated